## M6MGD13TW34DWG-P

134,217,728-BIT (8,388,608-WORD BY 16-BIT) CMOS FLASH MEMORY & 33,554,432-BIT (2,097,152-WORD BY 16-BIT) CMOS MOBILE RAM

Stacked-CSP (Chip Scale Package)

### Description

The M6MGD13TW34DWG-P is a Stacked Chip Scale Package (S-CSP) that contents 128M-bit Flash memory and 32M-bit Mobile RAM in a 72-pin Stacked CSP with leaded solder ball.

128M-bit Flash memory is a 8,388,608 words, single power supply and high performance non-volatile memory fabricated by CMOS technology for the peripheral circuit and DINOR IV (Divided bit-line NOR IV) architecture for the memory cell. All memory blocks are locked and can not be programmed or erased, when F-WP# is Low. Using Software Lock Release function, program or erase operation can be executed.

32M-bit Mobile RAM is a 2,097,152 words high density RAM fabricated by CMOS technology for the peripheral circuit and DRAM cell for the memory array. The interface is compatible to an asynchronous SRAM.

The cells are automatically refreshed and the refresh control is not required for system. The device also has the partial block refresh scheme and the power down mode by writing the command.

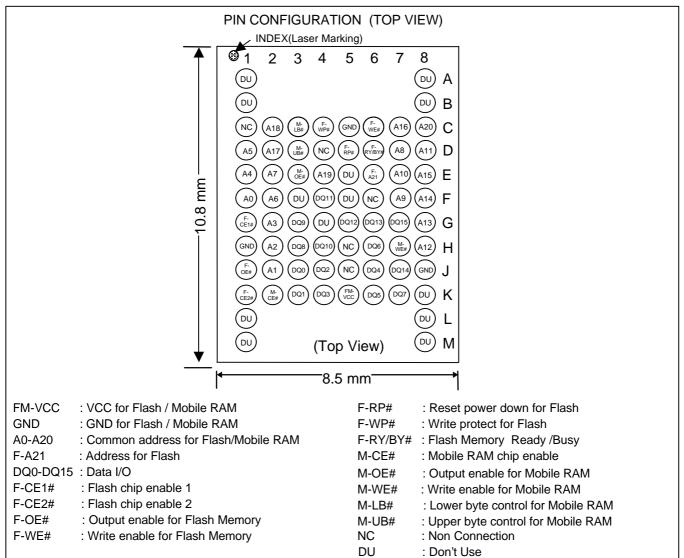
The M6MGD13TW34DWG-P is suitable for a high performance cellular phone and a mobile PC that are required to be small mounting area, weight and small power dissipation.

#### Features

Access Time	Flash	70ns (Max.)		
	Mobile RAM	80ns (Max.)		
Supply Voltage		FM-VCC=2.7 ~ 3.0V		
Ambient Temperature		Ta= -40 ~ 85 degree		
Package		72pin S-CSP,		
		Ball pitch 0.80mm Outer-ball:Sn - Pb		

### Application

Mobile communication products

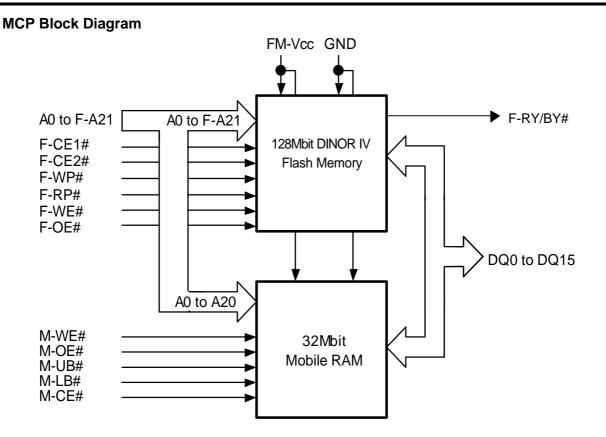




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Note: In the 128M-bit DINOR(IV) Flash Memory lower 64Mbit is selected by F-CE1#="L" and upper 64Mbit is done by F-CE2#="L". Never select each chip at the same time.
In the data sheet there are "VCC"s which mean "FM-VCC" (Common Vcc for Flash / Mobile RAM).
In the Flash Memory part they mean A21, OE# and WE# are F-A21, F-OE# and F-WE#.
In the Mobile RAM part UB#, LB#, OE# and WE# are M-UB#, M-DE#, M-OE# and M-WE#, respectively.

### Capacitance

Symbol	Parameter		Conditions	Limits			Unit
				Min.	Тур.	Max.	
CIN	Input capacitance	F-A21-A0, F-OE#, F-WE#, F-CE1#, F-CE2#, F-WP#, F-RP#, M-OE#, M-WE#, M-CE#, M-LB#, M-UB#	Ta=25°C, f=1MHz, Vin=Vout=0V			26	pF
соит	Output Capacitance	DQ15-DQ0, F-RY/BY#				34	pF



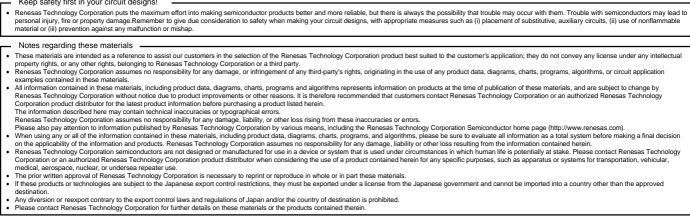
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#### Keep safety first in your circuit designs!



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